## DISCRETE SEMICONDUCTORS



BLV193 UHF power transistor

**Product specification** 

March 1993







## **UHF** power transistor

**BLV193** 

#### **FEATURES**

- Emitter ballasting resistors for an optimum temperature profile
- Gold metallization ensures excellent reliability.

### **DESCRIPTION**

NPN silicon planar epitaxial transistor intended for common emitter class-A and class-AB operation in the 900 MHz communications band.

The transistor has a SOT171 flange envelope with a ceramic cap. All leads are isolated from the mounting base.

#### **PINNING - SOT171**

PIN	DESCRIPTION
1	emitter
2	emitter
3	base
4	collector
5	emitter
6	emitter

### **QUICK REFERENCE DATA**

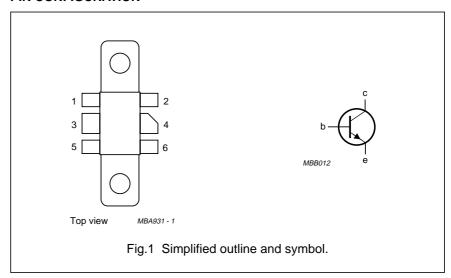
RF performance at  $T_h = 25$  °C in a common emitter test circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	ηc (%)	d <sub>im</sub> (dB) (note 1)	
c.w. class-AB	900	12.5	12	≥ 6.5	≥ 50	_	
c.w. class-A	900	12	6 (PEP)	typ. 11	_	typ30	

#### Note

1. 2-tone measurement,  $f_p = 900 \text{ MHz}$ ,  $f_q = 901 \text{ MHz}$ .

#### **PIN CONFIGURATION**



### **WARNING**

## Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

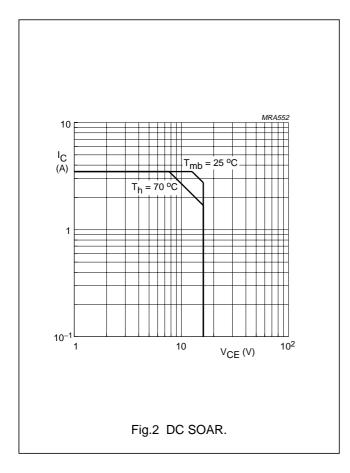
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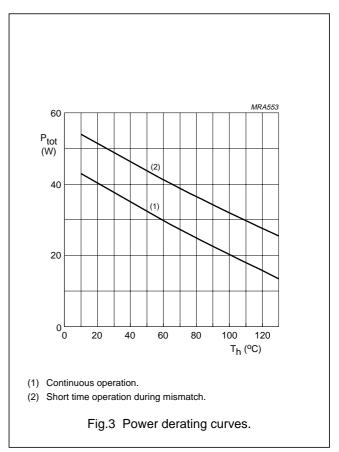
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### **LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	36	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	16	V
$V_{EBO}$	emitter-base voltage	open collector	_	3	V
I <sub>C</sub>	collector current	DC or average value	_	3.5	А
P <sub>tot</sub>	total power dissipation	up to T <sub>mb</sub> = 25 °C	_	44	W
T <sub>stg</sub>	storage temperature range		-65	150	°C
Tj	junction temperature		_	200	°C





### THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	THERMAL RESISTANCE
R <sub>th j-mb</sub>	from junction to mounting base	$P_{dis} = 44 \text{ W}; T_{mb} = 25 ^{\circ}\text{C}$	4.0 K/W
R <sub>th mb-h</sub>	from mounting base to heatsink		0.4 K/W

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## **CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	open emitter; I <sub>c</sub> = 20 mA	36	_	_	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	open base; I <sub>c</sub> = 40 mA	16	_	_	V
V <sub>(BR)EBO</sub>	emitter-base breakdown voltage	open collector; I <sub>E</sub> = 0.5 mA	3	-	_	V
I <sub>CES</sub>	collector-emitter leakage current	V <sub>CE</sub> = 16 V; V <sub>BE</sub> = 0	_	-	1	mA
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 10 V; I <sub>c</sub> = 1.2 A; note 1	25	60	_	
C <sub>c</sub>	collector capacitance	$V_{CB} = 12.5 \text{ V};$ $I_E = I_e = 0;$ $f = 1 \text{ MHz}$	-	24.5	_	pF
C <sub>re</sub>	feedback capacitance	V <sub>CE</sub> = 12.5 V; I <sub>c</sub> = 0; f = 1 MHz	-	13	_	pF
C <sub>c-mb</sub>	collector-mounting base capacitance		_	2	_	pF

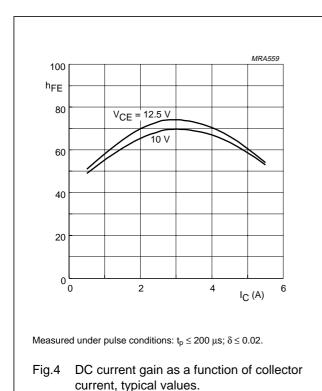
### Note

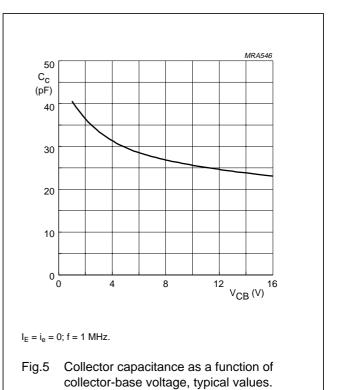
1. Measured under pulse conditions:  $t_p \leq 200~\mu s;~\delta \leq 0.02.$ 

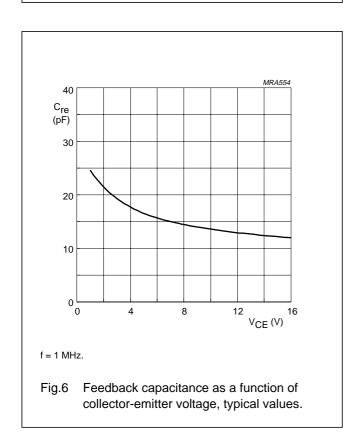
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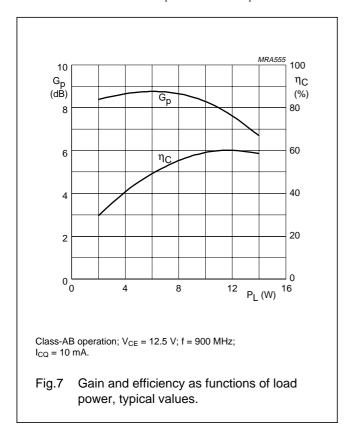
### **APPLICATION INFORMATION**

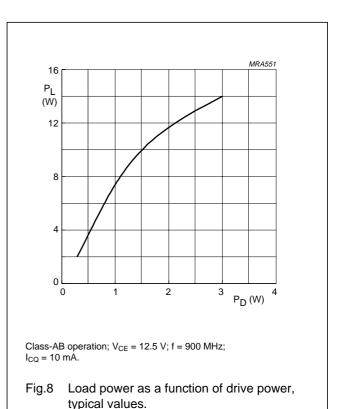
RF performance at  $T_h = 25$  °C in a common emitter test circuit;  $R_{th j-mb} = 0.4$  K/W.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	I <sub>CQ</sub> (A)	P <sub>L</sub> (W)	G <sub>P</sub> (dB)	η <sub>c</sub> <b>(%)</b>	d <sub>im</sub> (dB) (note 1)
c.w. class-AB	900	12.5	0.01	12	≥ 6.5	> 50	_
					typ. 7.5	typ. 60	
c.w. class-A	900	12	1.3	6 (PEP)	typ. 11	_	typ30

#### Note

1. 2-tone measurement,  $f_p = 900 \text{ MHz}$ ,  $f_q = 901 \text{ MHz}$ .





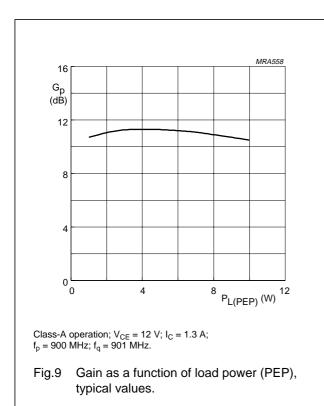
## Ruggedness in class-AB operation

The BLV193 is capable of withstanding a load mismatch corresponding to VSWR = 10:1 through all phases under the following conditions:

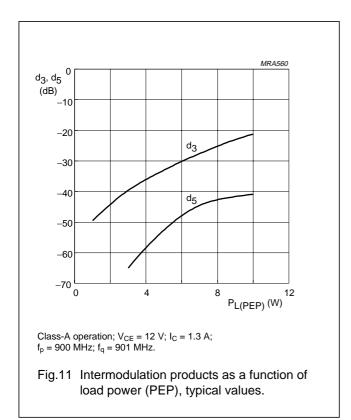
 $V_{CE}$  = 15.5 V, f = 900 MHz,  $T_h$  = 25 °C,  $R_{th\ j\text{-mb}}$  = 0.4 K/W, and rated output power.

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power (PEP), typical values.

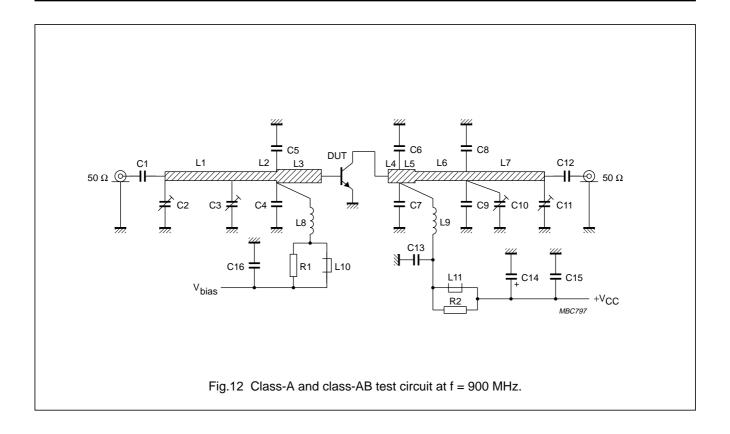


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## List of components (see test circuit)

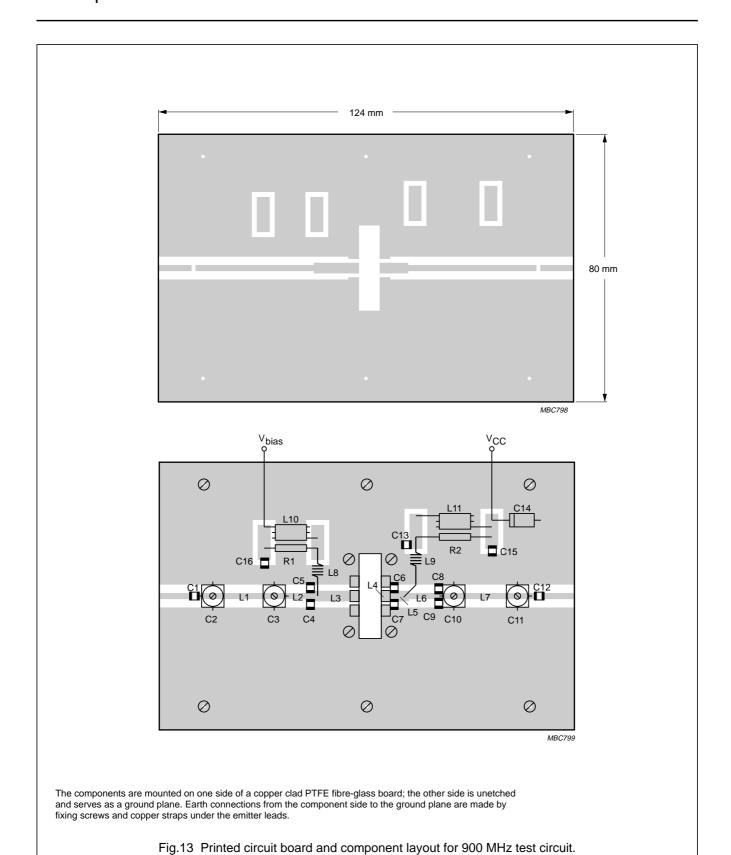
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C12	multilayer ceramic chip capacitor (note 1)	33 pF		
C2, C3, C10, C11	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C4, C5	multilayer ceramic chip capacitor (note 1)	4.7 pF		
C6, C7	multilayer ceramic chip capacitor (note 1)	5.6 pF		
C8, C9	multilayer ceramic chip capacitor (note 1)	3.3 pF		
C13	multilayer ceramic chip capacitor (note 1)	10 pF		
C14	electrolytic capacitor	6.8 μF, 63 V		
C15	multilayer ceramic chip capacitor (note 1)	330 pF		
C16	multilayer ceramic chip capacitor	100 nF		2222 852 47104
L1, L7	stripline (note 2)	50 Ω	length 29 mm; width 2.4 mm	
L2	stripline (note 2)	50 Ω	length 6 mm; width 2.4 mm	
L3	stripline (note 2)	42.7 Ω	length 13.1 mm; width 3 mm	
L4	stripline (note 2)	42.7 Ω	length 4.4 mm; width 3 mm	
L5	stripline (note 2)	42.7 Ω	length 4.6 mm; width 3 mm	
L6	stripline (note 2)	50 Ω	length 7 mm; width 2.4 mm	
L8	4 turns closely wound enamelled 0.4 mm copper wire	60 nH	int. dia 3 mm; leads 2 × 5 mm	
L9	4 turns enamelled 1 mm copper wire	45 nH	int. dia. 4 mm; leads 2 × 5 mm	
L10, L11	grade 3B Ferroxcube wideband HF choke			4312 020 36642
R1, R2	metal film resistor	10 Ω, 0.25 W		

## Notes

- 1. American Technical Ceramics type 100A or capacitor of the same quality.
- 2. The striplines are on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric ( $\epsilon_r$  = 2.2), thickness 1/32 inch.

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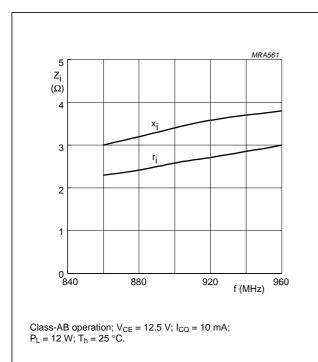


Fig.14 Input impedance (series components) as a function of frequency, typical values.

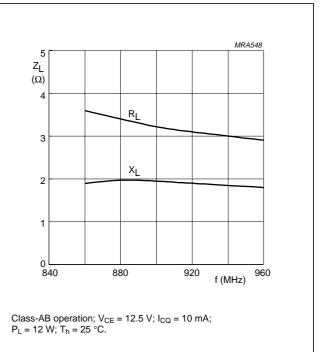
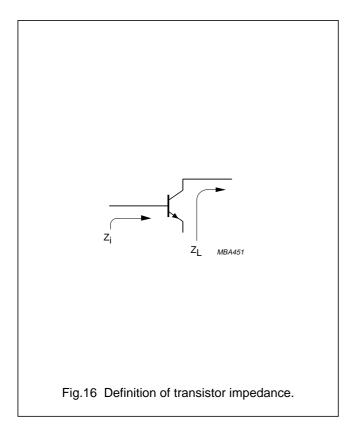
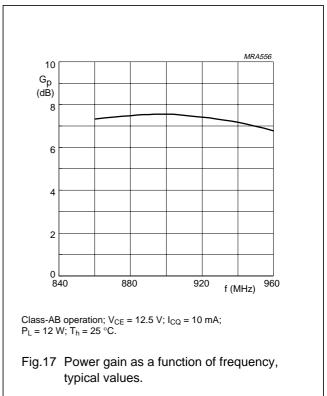


Fig.15 Load impedance (series components) as a function of frequency, typical values.





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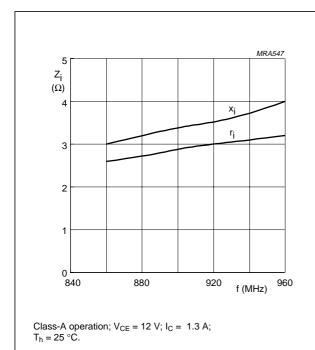


Fig.18 Input impedance (series components) as a function of frequency, typical values.

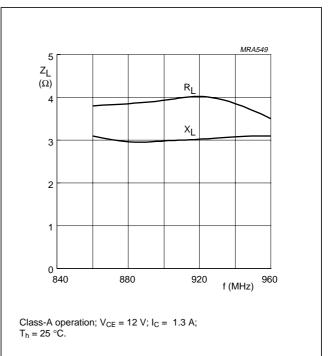
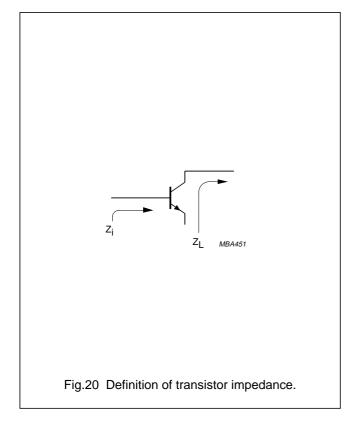
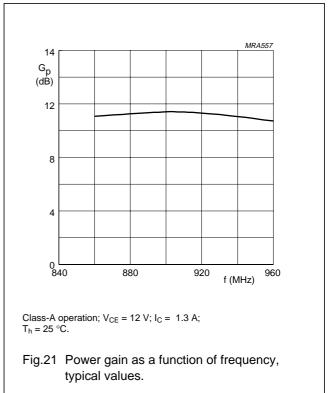


Fig.19 Load impedance (series components) as a function of frequency, typical values.





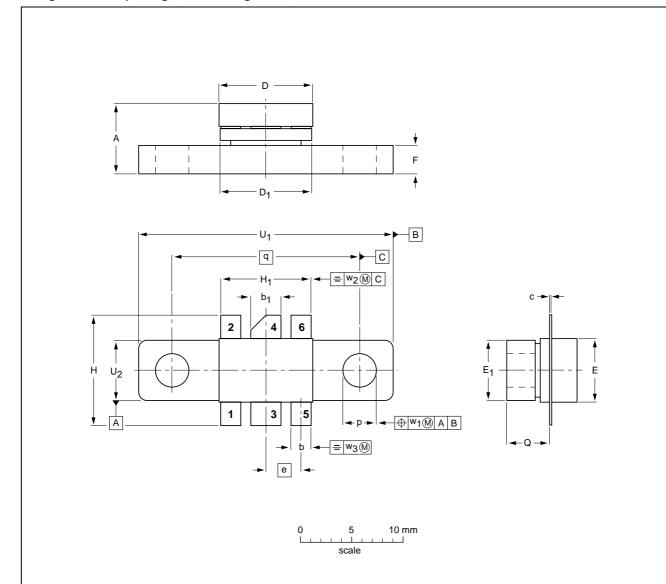
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## **PACKAGE OUTLINE**

## Flanged ceramic package; 2 mounting holes; 6 leads

SOT171A



## DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	b <sub>1</sub>	С	D	D <sub>1</sub>	Е	E <sub>1</sub>	е	F	н	Н1	р	Q	q	U <sub>1</sub>	U <sub>2</sub>	w <sub>1</sub>	w <sub>2</sub>	w <sub>3</sub>
mm	6.81 6.07	2.15 1.85	3.20 2.89	0.16 0.07	9.25 9.04		5.95 5.74		3.58	3.05 2.54	11.31 10.54		3.43 3.17	4.32 4.11	18.42	24.90 24.63	6.00 5.70	0.51	1.02	0.26
inches	0.268 0.239	0.085 0.073						0.236 0.224	0.140	0.120 0.100	0.445 0.415	0.365 0.355	0.135 0.125	0.170 0.162	0.725	0.980 0.970	0.236 0.224	0.02	0.04	0.01

OUTLINE		REFER	EUROPEAN			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT171A						97-06-28

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### **DEFINITIONS**

Data Sheet Status					
Objective specification	This data sheet contains target or goal specifications for product development.				
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.				
Product specification	This data sheet contains final product specifications.				
Limiting values					
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.					

## **Application information**

Where application information is given, it is advisory and does not form part of the specification.

### **LIFE SUPPORT APPLICATIONS**

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.